Notice of References Cited Application/Control No. 10/535,190 Examiner Timothy C. Vanoy Applicant(s)/Patent Under Reexamination CAMARO ET AL. Page 1 of 1

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NON-PATENT DOCUMENTS

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	υ	The English abstract of the reference titled "Investigation of the interaction between Co sulfide coatings and Cu(I) ions by cyclic voltammetry and XPS" by Valiuliene et al., Journal of Solid State Electrochemistry Vol. 6 No. 6 pgs. 396-402 (2002).					
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